FAIRCHILD
SEMICONDUCTOR®

February 2008

74VCX38
Low Voltage Quad 2-Input NAND Gate with Open Drain Outputs and 3.6V Tolerant Inputs and Outputs

Features

- 1.2V to 3.6V V_{CC} supply operation
- 3.6V tolerant inputs and outputs
- t_{PD}:
- 2.8ns max. for 3.0V to 3.6V V_{CC}
- Power-Off high impedance inputs and outputs
- Static Drive (I_{OL}):
  - +24mA @ 3.0V V_{CC}
- Uses patented Quiet Series™ noise/EMI reduction circuitry
- Latchup performance exceeds JEDEC 78 conditions
- ESD performance:
  - Human body model > 2000V
  - Machine model > 250V
- Leadless DQFN package

General Description

The VCX38 contains four 2-input NAND gates with open drain outputs. This product is designed for low voltage (1.2V to 3.6V) V_{CC} applications with I/O compatibility up to 3.6V.

The VCX38 is fabricated with advanced CMOS technology to achieve high-speed operation while maintaining CMOS low power dissipation.

Ordering Information

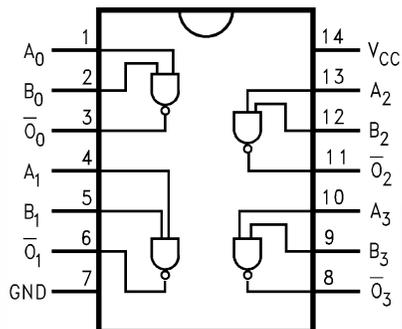| Order Number	Package Number	Package Description
74VCX38M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74VCX38BQX[1]	MLP14A	14-Terminal Depopulated Quad Very-Thin Flat Pack No Leads (DQFN), JEDEC MO-241, 2.5 x 3.0mm
74VCX38MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Note:

1. DQFN package available in Tape and Reel only.

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.
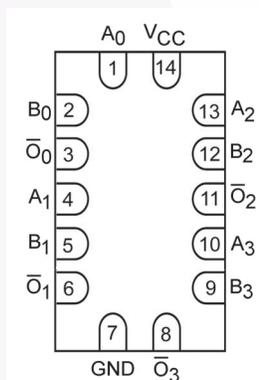
🌿 All packages are lead free per JEDEC: J-STD-020B standard.

Connection Diagrams
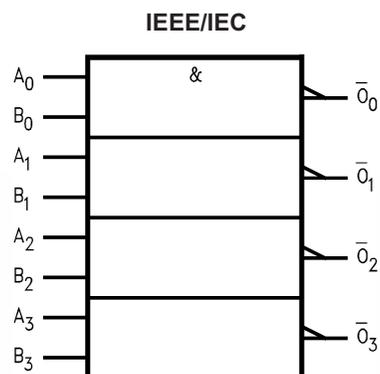
Pin Assignments for SOIC and TSSOP

A_0	1	14	V_{CC}
B_0	2	13	A_2
$\overline{O}_0$	3	12	B_2
A_1	4	11	$\overline{O}_2$
B_1	5	10	A_3
$\overline{O}_1$	6	9	B_3
GND	7	8	$\overline{O}_3$

Pad Assignments for DQFN

	A_0	V_{CC}	
	1	14	
B_0	2	13	A_2
$\overline{O}_0$	3	12	B_2
A_1	4	11	$\overline{O}_2$
B_1	5	10	A_3
$\overline{O}_1$	6	9	B_3
	7	8	
	GND	$\overline{O}_3$	

(Top View)

Logic Symbol

IEEE/IEC

A_0	&	$\overline{O}_0$
B_0		
A_1		$\overline{O}_1$
B_1		
A_2		$\overline{O}_2$
B_2		
A_3		$\overline{O}_3$
B_3		

Pin Description

Pin Names	Description
A_n, B_n	Inputs
$\overline{O}_n$	Outputs

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
V_{CC}	Supply Voltage	–0.5V to +4.6V
V_I	DC Input Voltage	–0.5V to 4.6V
V_O	Output Voltage[2]	–0.5V to 4.6V
I_{IK}	DC Input Diode Current, $V_I < 0V$	–50mA
I_{OK}	DC Output Diode Current, $V_O < 0V$	–50mA
I_{OL}	DC Output Source/Sink Current	+50mA
I_{CC} or GND	Supply Pin	±100mA
T_{STG}	Storage Temperature Range	–65°C to +150°C

Note:

2. I_O Absolute Maximum Rating must be observed.

Recommended Operating Conditions[3]

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Rating
V_{CC}	Power Supply Operating	1.2V to 3.6V
V_I	Input Voltage	–0.3V to 3.6V
V_O	Output Voltage	0V to V_{CC}
I_{OL}	Output Current	
	$V_{CC} = 3.0V$ to 3.6V	±24mA
	$V_{CC} = 2.3V$ to 2.7V	±18mA
	$V_{CC} = 1.65V$ to 2.3V	±6mA
	$V_{CC} = 1.4V$ to 1.6V	±2mA
	$V_{CC} = 1.2V$	± 100µA
T_A	Free Air Operating Temperature	–40°C to +85°C
$\Delta t / \Delta V$	Minimum Input Edge Rate, $V_{IN} = 0.8V$ to 2.0V, $V_{CC} = 3.0V$	10ns/V

Note:

3. Floating or unused inputs must be held HIGH or LOW

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	Conditions	Min	Max	Units
V_{IH}	HIGH Level Input Voltage	2.7–3.6		2.0		V
		2.3–2.7		1.6		
		1.65–2.3		$0.65 \times V_{CC}$		
		1.4–1.6		$0.65 \times V_{CC}$		
		1.2		$0.65 \times V_{CC}$		
V_{IL}	LOW Level Input Voltage	2.7–3.6			0.8	V
		2.3–2.7			0.7	
		1.65–2.3			$0.35 \times V_{CC}$	
		1.4–1.6			$0.35 \times V_{CC}$	
		1.2			$0.05 \times V_{CC}$	
V_{OL}	LOW Level Output Voltage	2.7–3.6	$I_{OL} = 100\mu A$		0.2	V
		2.7	$I_{OL} = 12mA$		0.4	
		3.0	$I_{OL} = 18mA$		0.4	
		3.0	$I_{OL} = 24mA$		0.55	
		2.3–2.7	$I_{OL} = 100\mu A$		0.2	
		2.3	$I_{OL} = 12mA$		0.4	
		2.3	$I_{OL} = 18mA$		0.6	
		1.65–2.3	$I_{OL} = 100\mu A$		0.2	
		1.65	$I_{OL} = 6mA$		0.3	
		1.4–1.6	$I_{OL} = 100\mu A$		0.2	
		1.4	$I_{OL} = 2mA$		0.35	
		1.2	$I_{OL} = 100\mu A$		0.05	
I_I	Input Leakage Current	1.2–3.6	$0 \leq V_I \leq 3.6V$		±5.0	μA
I_{OFF}	Power-Off Leakage Current	0	$0 \leq (V_I, V_O) \leq 3.6V$		10.0	μA
I_{CC}	Quiescent Supply Current	1.2–3.6	$V_I = V_{CC}$ or GND		20.0	μA
			$V_{CC} \leq (V_I) \leq 3.6V$		±20.0	
ΔI_{CC}	Increase in I_{CC} per Input	2.7–3.6	$V_{IH} = V_{CC} - 0.6V$		750	μA
I_{OHZ}	Off State Current	1.2–3.6	$V_O = 3.6$		10.0	μA

AC Electrical Characteristics[4]

Symbol	Parameter	V_{CC} (V)	Conditions	T_A = −40°C to +85°C		Units	Figure Number
				Min.	Max.		
t_{PZL}, t_{PZH}	Propagation Delay	3.3 ± 0.3	C_L = 30pF, R_L = 500Ω	0.6	2.8	ns	Fig. 1
		2.5 ± 0.2		0.8	3.7		Fig. 2
		1.8 ± 0.15		1.0	6.7		
		1.5 ± 0.1	C_L = 15pF, R_L = 2kΩ	1.0	13.4		Fig. 3
		1.2			33.5		Fig. 4
t_{OSHL}, t_{OSLH}	Output to Output Skew[5]	3.3 ± 0.3	C_L = 30pF, R_L = 500Ω		0.5	ns	
		2.5 ± 0.2			0.5		
		1.8 ± 0.15			0.75		
		1.5 ± 0.1	C_L = 15pF, R_L = 2kΩ		1.5		
		1.2			1.5		

Note:

4. For C_L = 50pF, add approximately 300ps to the AC Maximum specification.

5. Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}).

Dynamic Switching Characteristics

Symbol	Parameter	V_{CC} (V)	Conditions	T_A = 25°C	Unit
				Typical	
V_{OLP}	Quiet Output Dynamic Peak V_{OL}	1.8	C_L = 30pF, V_{IH} = V_{CC}, V_{IL} = 0V	0.25	V
		2.5		0.6	
		3.3		0.8	
V_{OLV}	Quiet Output Dynamic Valley V_{OL}	1.8	C_L = 30pF, V_{IH} = V_{CC}, V_{IL} = 0V	−0.25	V
		2.5		−0.6	
		3.3		−0.8	

Capacitance

Symbol	Parameter	Conditions	T_A = +25°C	Units
			Typical	
C_{IN}	Input Capacitance	V_I = 0V or V_{CC}, V_{CC} = 1.8V, 2.5V or 3.3V	6.0	pF
C_{OUT}	Output Capacitance	V_I = 0V or V_{CC}, V_{CC} = 1.8V, 2.5V or 3.3V	7.0	pF
C_{PD}	Power Dissipation Capacitance	V_I = 0V or V_{CC}, f = 10MHz, V_{CC} = 1.8V, 2.5V or 3.3V	20.0	pF

AC Loading and Waveforms (V_{CC} 3.3V ± 0.3V to 1.8V ± 0.15V)
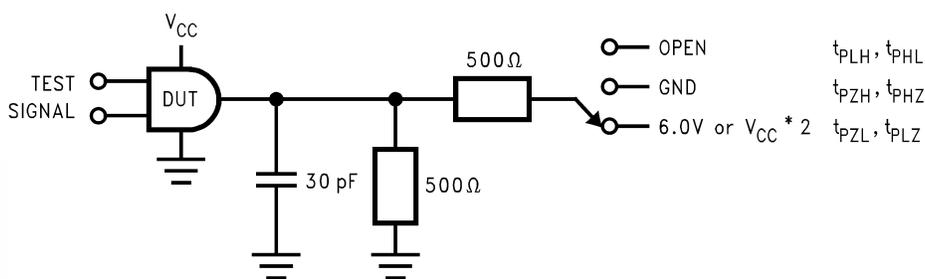
Test	Switch
t_{PZL}, t_{PLZ}	6V at V_{CC} = 3.3 ± 0.3V;
	$V_{CC} \times 2$ at V_{CC} = 2.5V ± 0.2V; 1.8V

Figure 1. AC Test Circuit
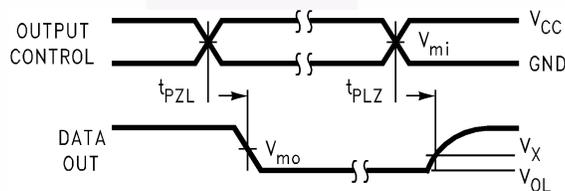
Symbol	V_{CC}		
	3.3V ± 0.3V	2.5V ± 0.2V	1.8V ± 0.15V
V_{mi}	1.5V	V_{CC} / 2	V_{CC} / 2
V_{mo}	1.5V	V_{CC} / 2	V_{CC} / 2
V_x	V_{OL} + 0.3V	V_{OL} + 0.15V	V_{OL} + 0.15V

Figure 2. Waveform for Open Drain, Inverting and Non-inverting Functions

AC Loading and Waveforms (V_{CC} 1.5 ± 0.1V to 1.2V)
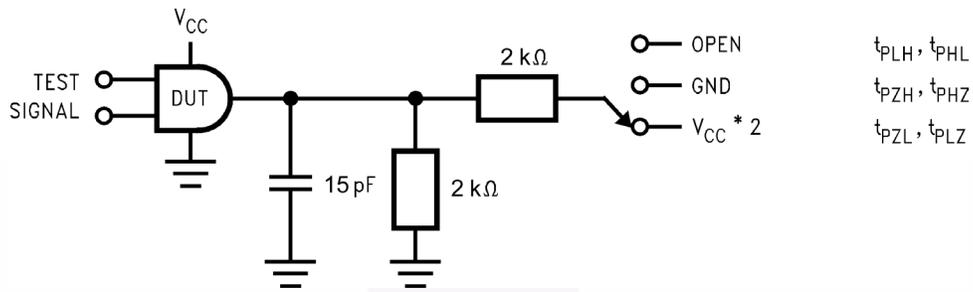
Test	Switch
t_{PZL}, t_{PLZ}	V_{CC} x 2 at V_{CC} = 1.5V ± 0.1V

Figure 3. AC Test Circuit
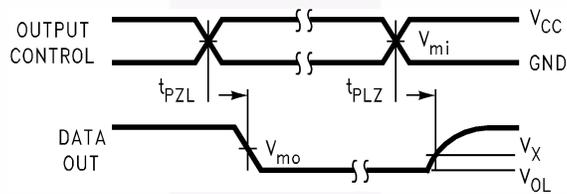
Symbol	V_{CC} 1.5V ± 0.1V
V_{mi}	V_{CC} / 2
V_{mo}	V_{CC} / 2
V_X	V_{OL} + 0.1V
V_Y	V_{OH} − 0.1V

Figure 4. 3-STATE Output Low Enable and Disable Times for Low Voltage Logic

Tape and Reel Specification

Tape Format for DQFN

Package Designator	Tape Section	Number of Cavities	Cavity Status	Cover Tape Status
BQX	Leader (Start End)	125 (Typ.)	Empty	Sealed
	Carrier	3000	Filled	Sealed
	Trailer (Hub End)	75 (Typ.)	Empty	Sealed

Tape Dimensions inches (millimeters)
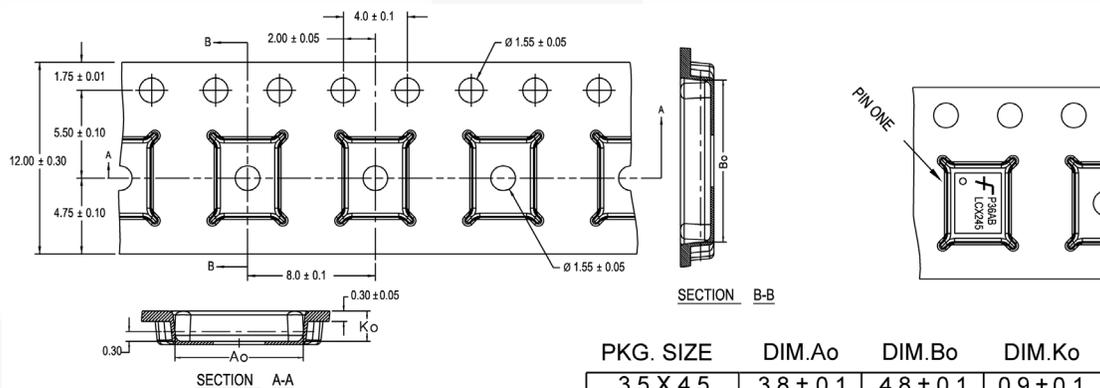
PKG. SIZE	DIM.Ao	DIM.Bo	DIM.Ko
3.5 X 4.5	3.8 ± 0.1	4.8 ± 0.1	0.9 ± 0.1
3.0 X 3.0	3.3 ± 0.1	3.3 ± 0.1	0.9 ± 0.1
2.5 X 4.5	2.8 ± 0.1	4.8 ± 0.1	0.9 ± 0.1
2.5 X 3.5	2.8 ± 0.1	3.8 ± 0.1	0.9 ± 0.1
2.5 X 3.0	2.8 ± 0.1	3.3 ± 0.1	0.9 ± 0.1
2.5 X 2.5	2.8 ± 0.1	2.8 ± 0.1	0.9 ± 0.1

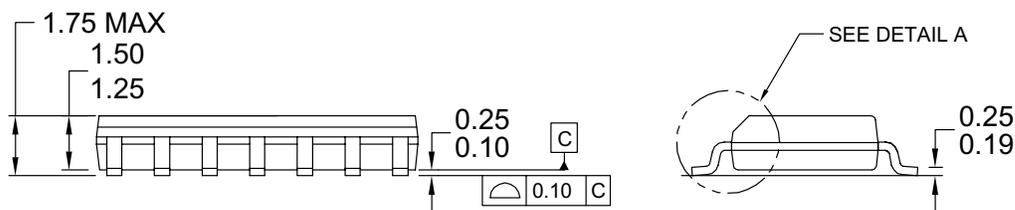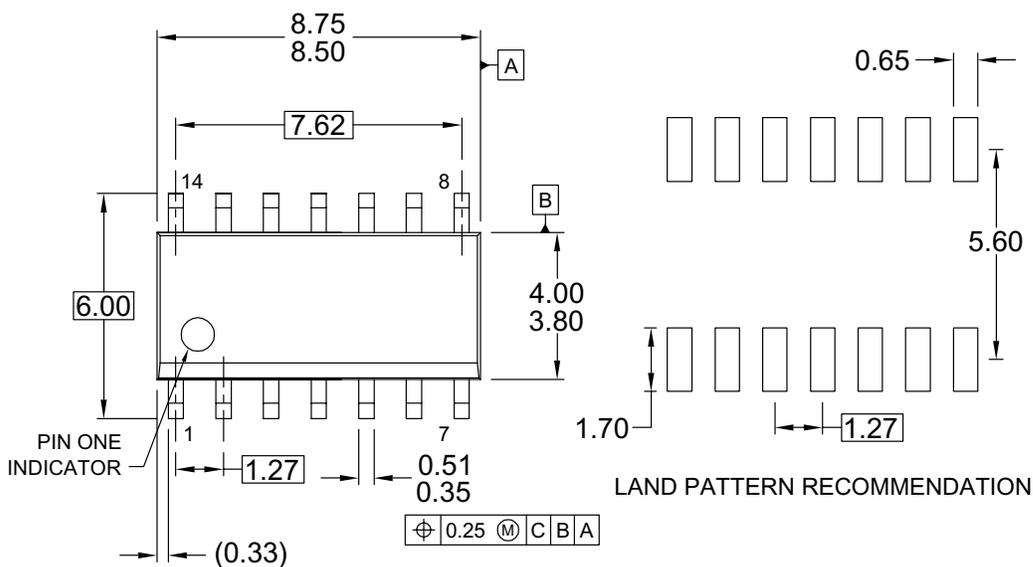DIMENSIONS ARE IN MILLIMETERS

NOTES: unless otherwise specified

1. Cummulative pitch for feeding holes and cavities (chip pockets) not to exceed 0.008[0.20] over 10 pitch span.
2. Smallest allowable bending radius.
3. Thru hole inside cavity is centered within cavity.
4. Tolerance is ±0.002[0.05] for these dimensions on all 12mm tapes.
5. Ao and Bo measured on a plane 0.120[0.30] above the bottom of the pocket.
6. Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
7. Pocket position relative to sprocket hole measured as true position of pocket. Not pocket hole.
8. Controlling dimension is millimeter. Diemension in inches rounded.

Reel Dimensions inches (millimeters)
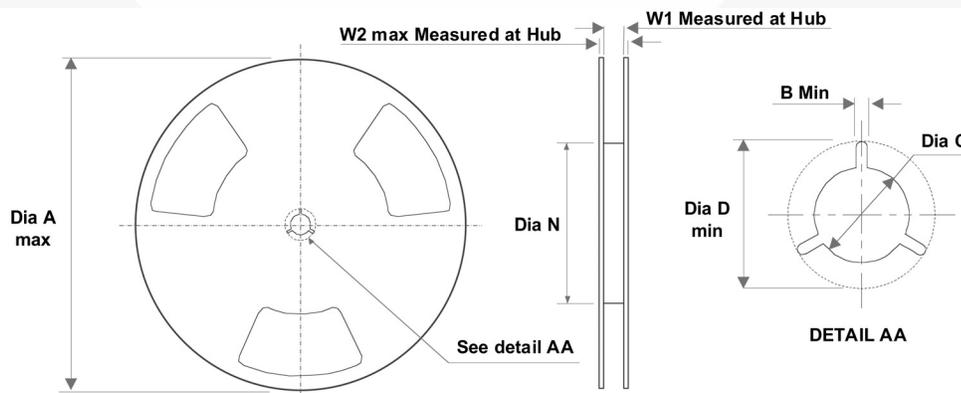
Tape Size	A	B	C	D	N	W1	W2
12mm	13.0 (330.0)	0.059 (1.50)	0.512 (13.00)	0.795 (20.20)	2.165 (55.00)	0.488 (12.4)	0.724 (18.4)

Physical Dimensions

8.75
8.50

A

7.62

14   8

B

6.00

4.00
3.80

PIN ONE
INDICATOR

1   7

1.27   0.51
0.35

⊕ 0.25 Ⓜ C B A

(0.33)

0.65

5.60

1.70   1.27

LAND PATTERN RECOMMENDATION

1.75 MAX
1.50
1.25

0.25
0.10   C

⌒ 0.10 C

SEE DETAIL A

0.25
0.19

NOTES: UNLESS OTHERWISE SPECIFIED

A) THIS PACKAGE CONFORMS TO JEDEC
   MS-012, VARIATION AB, ISSUE C,
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS DO NOT INCLUDE MOLD
   FLASH OR BURRS.
D) LANDPATTERN STANDARD:
   SOIC127P600X145-14M
E) DRAWING CONFORMS TO ASME Y14.5M-1994
F) DRAWING FILE NAME: M14AREV13

0.50
0.25   X 45°

R0.10

R0.10   GAGE PLANE

8°
0°   0.36

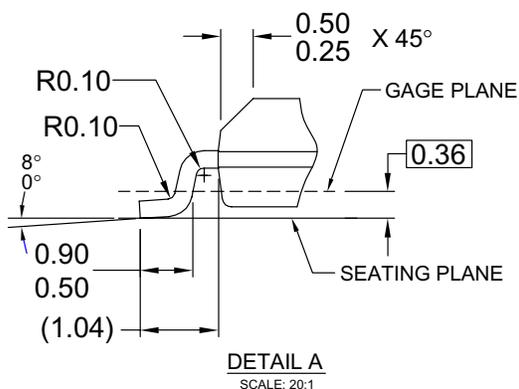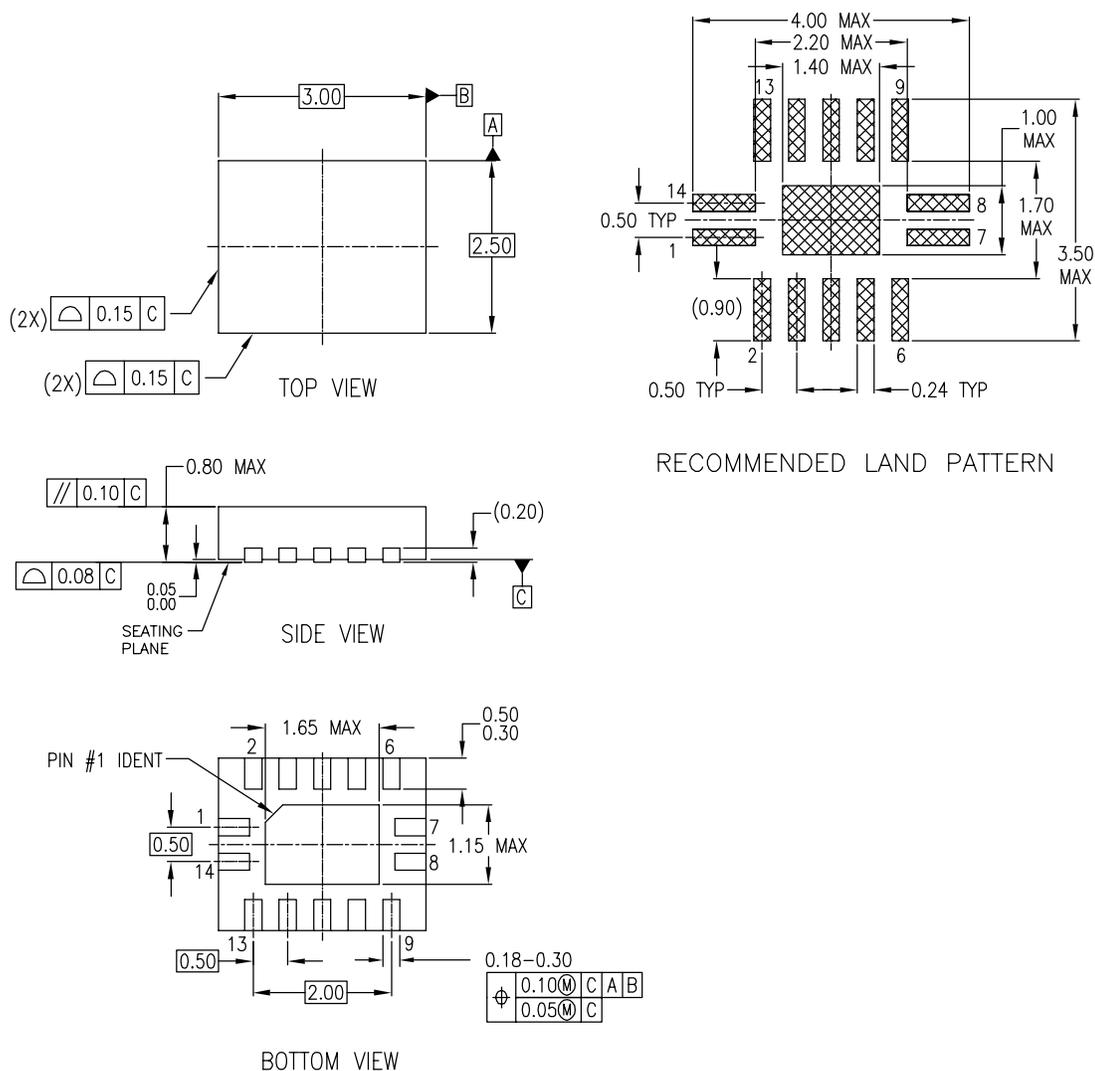0.90
0.50

(1.04)

SEATING PLANE

DETAIL A
SCALE: 20:1

Figure 5. 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow

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Physical Dimensions (Continued)

TOP VIEW

3.00 B
A
2.50
(2X) 0.15 C
(2X) 0.15 C

RECOMMENDED LAND PATTERN

4.00 MAX
2.20 MAX
1.40 MAX
13
9
1.00 MAX
14
0.50 TYP
8
1.70 MAX
1
7
3.50 MAX
(0.90)
2
6
0.50 TYP
0.24 TYP

SIDE VIEW

0.80 MAX
// 0.10 C
(0.20)
0.08 C
C
0.05
0.00
SEATING PLANE

BOTTOM VIEW

1.65 MAX
0.50
0.30
PIN #1 IDENT
2
6
1
7
0.50
1.15 MAX
14
8
13
9
0.50
2.00
0.18-0.30
0.10 (M) C A B
0.05 (M) C

NOTES:

A. CONFORMS TO JEDEC REGISTRATION MO-241, VARIATION AA
B. DIMENSIONS ARE IN MILLIMETERS.
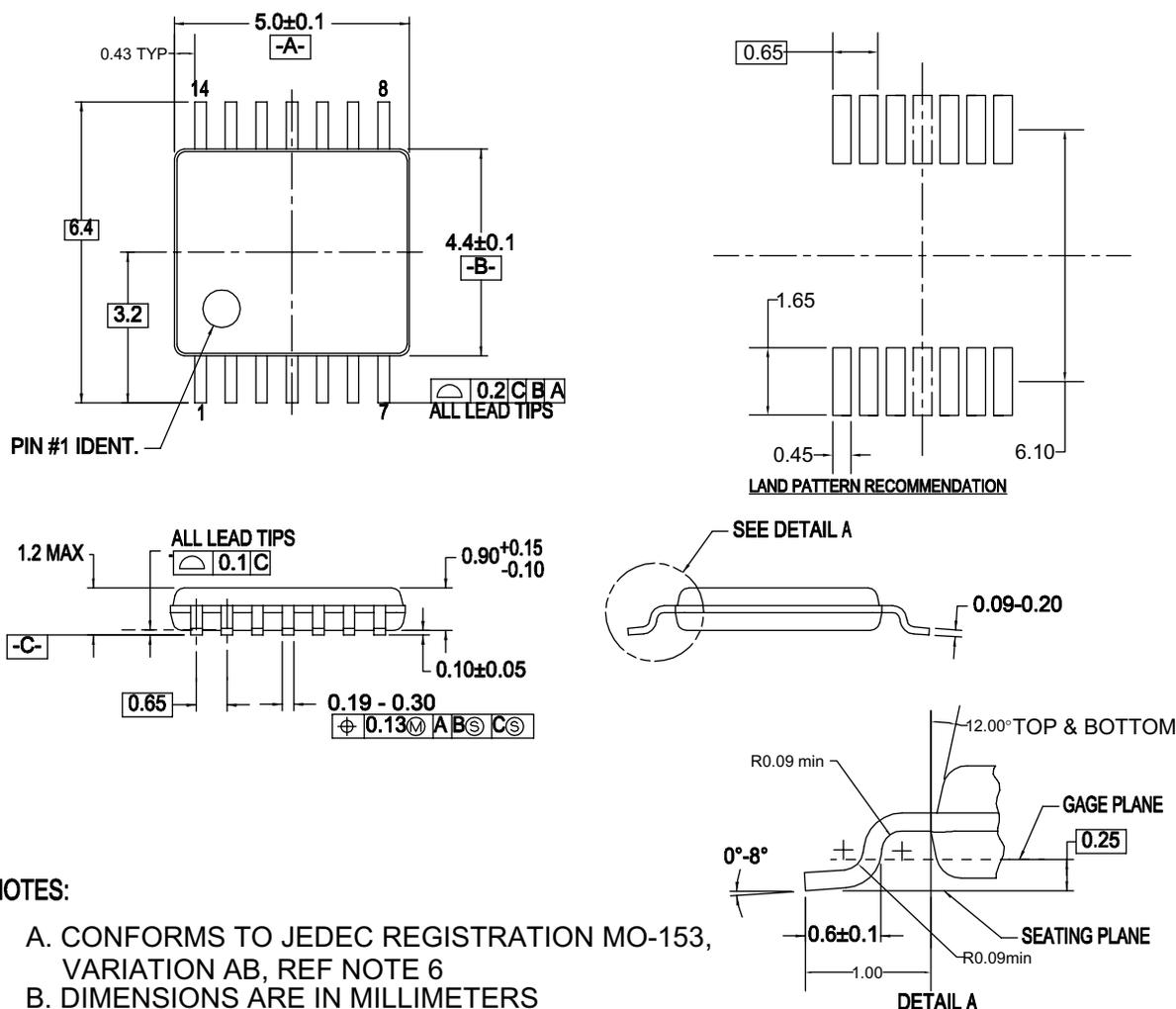C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

MLP14ArevA

Figure 6. 14-Terminal Depopulated Quad Very-Thin Flat Pack No Leads (DQFN), JEDEC MO-241, 2.5 x 3.0mm

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Physical Dimensions (Continued)

NOTES:

  A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION AB, REF NOTE 6

  B. DIMENSIONS ARE IN MILLIMETERS

  C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS

  D. DIMENSIONING AND TOLERANCES PER ANSI Y14.5M, 1982

  E. LANDPATTERN STANDARD: SOP65P640X110-14M

  F. DRAWING FILE NAME: MTC14REV6

Figure 7. 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

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RapidConfigure™
SMART START™
SPM®
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SuperSOT™-3
SuperSOT™-6
SuperSOT™-8

SupreMOS™
SyncFET™
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the power™ franchise
TinyBoost™
TinyBuck™
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